

Notice of References CitedApplication/Control No.
10/008,646Applicant(s)/Patent Under
Reexamination
PLATT, CHRISTOPHER LORENExaminer
Kevin M BernatzArt Unit
1773

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0181170	12-2002	Lin et al.	360/324.11
	B	US-5,942,342	08-1999	Hikosaka et al.	428/694R
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Tanaka, A., Shimizu, Y., Kishi, H., Nagaska, K., Kanai, H., and M. Oshikik IEEE Trans. Mag., 35(2), 1999, 700 - 705.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.